

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10511312	TANABE ET AL.
	<b>Examiner</b> Yeh, Eueng-nan	<b>Art Unit</b> 2624

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
(382/232) text search - see search outputs	2007/11/08	ey
EAST text search - see search outputs	2007/11/06	ey
PALM inventor search - see search outputs	2007/11/06	ey

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>